

INFORMATION DISCLOSURE CITATION IN AN APPLICATION			ATTY. DOCKET NO. 57810-101	SERIAL NO.		
(PTO-1449)			APPLICANT Nobuhiko ODA, et al.			
			FILING DATE April 23, 2004	GROUP		
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code - Number - Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation
A	A	P2002-98951	04/05/2002	SONY CORP		Yes <input type="checkbox"/> No <input type="checkbox"/> Japanese (w/ English Abstract)
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				
 EXAMINER			DATE CONSIDERED 9/24/06			

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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

INFORMATION DISCLOSURE CITATION IN AN APPLICATION  (PTO-1449)				ATTY. DOCKET NO. 57810-101	SERIAL NO. 10/830,088	
				APPLICANT Nobuhiko ODA, et al.		
				FILING DATE April 23, 2004	GROUP 2821	
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
AT	US	2002/0118327 A1	08/29/2002	Yamada et al.		
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						Yes
						No
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
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